

Notice of References Cited

Application/Control No.

10/565,977

Applicant(s)/Patent Under
Reexamination
TSUJI ET AL.

Examiner

MICHAEL M. BERNSHTEYN

Art Unit

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,593,043	07-2003	Suwa et al.	430/18
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	L	US-			
	M	US-			

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